

Notice of References Cited	Application/Control No. 10/511,734	Applicant(s)/Patent Under Reexamination PROTIC ET AL.	
	Examiner Shun Lee	Art Unit 2884	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hamacher et al., Performance of position -sensitive germanium detectors in nuclear reaction experiments, Nuclear Instruments & Methods in Physics Research, Vol. A295, no. 1-2 (October 1990), pp. 128-132.
	V	Luke et al., Amorphous Ge bipolar blocking contacts on Ge detectors, IEEE Transactions on Nuclear Science, Vol. 39, no. 4 (August 1992), pp. 590-594.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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